

INTERNATIONAL STANDARD

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**Industrial-process measurement and control – Programmable controllers –
Part 2: Equipment requirements and tests**

**Mesurage et contrôle des processus industriels – Automates programmables –
Partie 2: Exigences et essais des équipements**

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CONTENTS

FOREWORD.....	7
INTRODUCTION.....	9
1 Scope.....	10
2 Normative references	12
3 Terms, definitions, abbreviated terms, acronyms, conventions and symbols	13
3.1 Terms and definitions.....	13
3.2 Abbreviated terms, acronyms, conventions and symbols.....	18
4 Compliance and type tests.....	19
4.1 Compliance with this standard	19
4.2 Type tests.....	20
4.2.1 General	20
4.2.2 Equipment to be tested (equipment under test/EUT).....	20
4.2.3 Special features for EMC tests	23
4.2.4 Withstand test conditions.....	23
4.2.5 Climatic tests.....	23
4.2.6 Functionality verification with temperature	23
4.2.7 Verification procedure.....	27
4.2.8 Requirements for test programmes and proper functioning verification procedures (PFVPs) to be provided by the manufacturer	28
4.2.9 EMC Performance criteria.....	28
4.2.10 General facility/laboratory conditions for tests	29
4.3 Test report.....	29
5 Normal service conditions and requirements.....	30
5.1 General.....	30
5.2 Operating conditions and requirements.....	30
5.2.1 Ambient temperature and relative humidity	30
5.2.2 Altitude	34
5.3 Mechanical operating conditions and requirements	35
5.3.1 General	35
5.3.2 Vibrations	35
5.3.3 Shock	36
5.3.4 Free falls (portable and hand-held equipment).....	36
5.4 Transport and storage conditions and requirements	37
5.4.1 General	37
5.4.2 Ambient temperature and relative humidity	37
5.4.3 Altitude	39
5.4.4 Free falls (in manufacturer's original packaging).....	39
6 Functional requirements	40
6.1 General.....	40
6.2 Power input ports.....	41
6.2.1 Requirements	41
6.2.2 Verification of power input ports (a.c. or d.c.).....	42
6.3 Memory power back-up.....	46
6.3.1 Requirements	46
6.3.2 Verification of memory power back-up requirements	46
6.4 Digital I/Os.....	48

6.4.1	General	48
6.4.2	Positive logic digital I/Os (sinking inputs / sourcing outputs)	48
6.4.3	Negative logic digital I/Os (sourcing inputs / sinking outputs)	48
6.4.4	Digital inputs (positive logic, current sinking)	49
6.4.5	Digital outputs for alternating currents (positive logic, current sourcing)	52
6.4.6	Digital outputs for direct current (current sourcing)	57
6.4.7	Requirements for discrete channel compatibility with IEC 61131-9 SDCI	61
6.4.8	Special digital I/O interfaces	61
6.5	Analog I/Os	61
6.5.1	General	61
6.5.2	Analog inputs	61
6.5.3	Analog outputs	61
6.5.4	Analog temperature inputs	62
6.5.5	Requirements for analog channel compatibility with HART® (Highway Addressable Remote Transducer)	62
6.5.6	Verification of analog I/Os	62
6.6	Communication interface requirements	64
6.6.1	General	64
6.6.2	Verification of communication interface requirements	64
6.7	Main processing unit(s) and memory(ies) requirements	64
6.7.1	General	64
6.7.2	Verification of processing unit requirements	64
6.8	Remote input/output station (RIOS) requirements	65
6.8.1	General	65
6.8.2	Verification of local and remote I/O stations	65
6.9	Peripherals (PADTs, TEs, HMIs) requirements	66
6.9.1	General	66
6.9.2	Verification of peripheral (PADTs, TEs, HMIs) requirements	67
6.10	Self-tests and diagnostics requirements	67
6.10.1	General	67
6.10.2	Verification of self-tests and diagnostics	67
6.11	Functional earth	68
6.12	Requirements for information on normal service and function	68
7	Electromagnetic compatibility (EMC) requirements	68
7.1	General	68
7.2	Emission requirements	70
7.3	EMC immunity requirements	71
7.3.1	Immunity levels	71
7.3.2	Voltage dips and interruptions power ports	77
7.4	Requirements for information on EMC installation	78
8	Marking requirements and information to be provided by the manufacturer	78
8.1	Verification	78
8.2	General marking requirements	78
8.2.1	Minimum marking requirement	78
8.2.2	Functional identifications	79
8.2.3	Functional earth terminals markings	79
8.2.4	Documentation markings	79
8.3	Information format and content	79
8.3.1	Information format	79

8.3.2	Information content.....	80
8.3.3	Information on compliance with this standard.....	80
8.3.4	Information on shipping and storage	80
8.3.5	Information on a.c. and d.c. power supply.....	80
8.3.6	Information on digital inputs (current sinking)	81
8.3.7	Information on digital outputs for alternating currents (current sourcing)	81
8.3.8	Information on digital outputs for direct current (current sourcing).....	82
8.3.9	Information on analog inputs.....	82
8.3.10	Information on analog outputs	84
8.3.11	Information on communication interfaces	86
8.3.12	Information on main processing unit(s) and memory(ies)	86
8.3.13	Information on remote input/output station (RIOS)	86
8.3.14	Information on peripherals (PADTs, TEs, HMIs).....	87
8.3.15	Information on self-tests and diagnostics	87
8.4	Information on EMC installation	88
8.5	Information on reliability.....	88
Annex A (informative)	Temperature derating for altitude	89
A.1	Standard atmosphere modelling.....	89
A.1.1	Ambient temperature	89
A.1.2	Aerostatics equation	89
A.1.3	Air density	90
A.1.4	Radiation	90
A.1.5	Derating ratio.....	91
A.1.6	Comparison with IEEE1613	91
Annex B (informative)	Digital input standard operating range equations.....	93
Annex C (normative)	Zone C – EMC immunity levels	94
Annex D (normative)	Legacy techniques that are out-dated and not recommended for new design	97
D.1	Background	97
D.2	Ambient temperature	97
D.3	Type 2 digital input	97
D.3.1	Definition	97
D.3.2	Background	97
D.4	Analog inputs.....	98
D.5	Analog outputs.....	99
D.6	CRT displays	99
Annex E (informative)	Application reasoning for a.c. and d.c. interruptions	101
Annex F (normative)	Digital I/O: Current-sourcing input and current-sinking output.....	102
F.1	Digital I/O (negative logic).....	102
F.2	Function and verification	104
Bibliography		105
Figure 1	– Equipment in the scope and not in the scope	11
Figure 2	– Example EUT configurations	21
Figure 3	– General temperature test environment	24
Figure 4	– Vented equipment.....	25
Figure 5	– Non-vented equipment	26

Figure 6 – Panel mounted equipment extending through the wall of a cabinet	27
Figure 7 – Typical interface/port diagram of a modular control equipment	41
Figure 8 – Gradual shut-down/start-up test	44
Figure 9 – Fast supply voltage variation test	45
Figure 10 – Slow supply voltage variation test	45
Figure 11 – Positive logic (sinking inputs / sourcing outputs)	48
Figure 12 – U-I operation regions of current-sinking inputs	49
Figure 13 – Input Type 3 Diagnostic	51
Figure 14 – Temporary overload waveform for digital a.c. outputs	53
Figure 15 – Temporary overload waveform for digital d.c. outputs	58
Figure 16 – EMC zones	69
Figure A.1 – A small atmosphere element	89
Figure E.1 – d.c. distribution to control equipment and faults	101
Figure F.1 – Negative logic (sourcing inputs / sinking outputs)	102
Figure F.2 – Positive logic with faults	103
Figure F.3 – Negative logic with faults	104
Table 1 – Criteria to prove the performance of an EUT against EMC disturbances	29
Table 2 – General facility/laboratory conditions for tests	29
Table 3 – Operating environments, ambient temperature and relative humidity	30
Table 4 – Dry-heat withstand and immunity tests	31
Table 5 – Cold withstand and immunity tests	32
Table 6 – Change of temperature, withstand and immunity tests	33
Table 7 – Cyclic (12 + 12) damp-heat withstand test	34
Table 8 – Multiplication factors for equipment ambient temperature of operation at altitudes up to 5 000 m	35
Table 9 – Sinusoidal vibration conditions	35
Table 10 – Immunity vibration test	36
Table 11 – Immunity shock test	36
Table 12 – Free fall on concrete floor for portable and hand-held equipment	37
Table 13 – Storage environments, ambient temperature and relative humidity	38
Table 14 – Transportation environments, ambient temperature and humidity	38
Table 15 – Free fall on concrete floor in manufacturer's original packaging	39
Table 16 – Rated values and operating ranges of incoming power supply	41
Table 17 – Voltage interruptions (functional requirements)	42
Table 18 – Voltage ripple and frequency range immunity test	43
Table 19 – Gradual shut-down/start-up test	44
Table 20 – Supply voltage variation tests	44
Table 21 – Voltage interruptions immunity test (Functional tests)	46
Table 22 – Back-up duration withstand test	47
Table 23 – Change of energy source test	47
Table 24 – Operating ranges for digital inputs (current sinking)	50
Table 25 – Rated values and operating ranges for current sourcing digital a.c. outputs	52

Table 26 – Overload test circuit values	55
Table 27 – Endurance test circuit values.....	55
Table 28 – Overload and short-circuit tests for digital outputs	56
Table 29 – Rated values and operating ranges (d.c.) for current-sourcing digital d.c. outputs	57
Table 30 – Overload and short-circuit tests for digital outputs	60
Table 31 – Rated values and impedance limits for analog inputs	61
Table 32 – Rated values and impedance limits for analog outputs	61
Table 33 – Analog output overload immunity test	63
Table 34 – Insertion/withdrawal of removable units	66
Table 35 – EMC zones & protection considerations.....	70
Table 36 – Enclosure port tests, Zones A and B.....	71
Table 37 – Conducted immunity tests, Zone B	72
Table 38 – Conducted immunity tests, zone A.....	73
Table 39 – Electrostatic discharge immunity test.....	74
Table 40 – Radiated electromagnetic field immunity test.....	75
Table 41 – Power-frequency magnetic field immunity test	75
Table 42 – Fast transient burst immunity test.....	76
Table 43 – High-energy surge immunity test	76
Table 44 – Conducted r.f. immunity test.....	77
Table 45 – Voltage dips and interruptions (EMC requirements).....	77
Table 46 – Voltage dips and interruptions immunity test (EMC tests) ^f	78
Table 47 – Analog input static characteristics	83
Table 48 – Analog input dynamic characteristics.....	83
Table 49 – Analog input general characteristics	84
Table 50 – Analog input miscellaneous characteristics.....	84
Table 51 – Analog output static characteristics	84
Table 52 – Analog output dynamic characteristics.....	85
Table 53 – Analog output general characteristics	85
Table 54 – Analog output miscellaneous characteristics	85
Table A.1 – Component temperature derating with altitude, 2 000 m as reference	91
Table A.2 – Component temperature derating with altitude, 1 500 m as reference, and 20 °C at the sea level standard temperature	91
Table C.1 – Enclosure port tests, Zone C.....	94
Table C.2 – Conducted immunity tests, Zone C.....	95
Table C.3 – Damped oscillatory wave immunity test.....	96
Table D.1 – Standard operating ranges for Type 2 digital inputs (current sinking)	98
Table D.2 – Rated values and impedance limits for analog inputs	99
Table D.3 – Rated values and impedance limits for analog outputs	99

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**INDUSTRIAL-PROCESS MEASUREMENT AND CONTROL –
PROGRAMMABLE CONTROLLERS –****Part 2: Equipment requirements and tests****FOREWORD**

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International Standard IEC 61131-2 has been prepared by subcommittee 65B: Measurement and control devices, of IEC technical committee 65: Industrial-process measurement, control and automation.

This fourth edition cancels and replaces the third edition published in 2007. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) removal of safety requirements and instead pointing to IEC 61010-2-201;
- b) addition of negative logic digital inputs and outputs;
- c) addition of Type 3-d digital input;
- d) addition of 2,7 GHz to 6 GHz requirement for Radio-frequency electro-magnetic amplitude modulated immunity;

- e) clarification of temperature testing;
- f) clarification of type testing;
- g) deprecation of certain technologies;
- h) general update of multiple aspects of functionality and EMC;
- i) reorganization of clauses to associate requirements and verifications more closely.

The text of this standard is based on the following documents:

FDIS	Report on voting
65B/1083/FDIS	65B/1091/RVD

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61131 series, published under the general title *Industrial-process measurement and control – Programmable controllers*, can be found on the IEC website.

Future standards in this series will carry the new general title as cited above. Titles of existing standards in this series will be updated at the time of the next edition.

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INTRODUCTION

IEC 61131-2 is part of a series of standards on industrial control equipment, including programmable controllers, and their associated peripherals and should be read in conjunction with the other parts of the series. However, it can be read and applied alone.

Where a conflict exists between this and other IEC standards, the provisions of this standard should be considered to govern in the area of industrial control equipment, including programmable controllers, and their associated peripherals.

This standard defines for industrial control equipment the following:

- Testing and verifications methods (Clause 4);
- Operating conditions (5.2);
- Temperature and climatic tests (5.2.1);
- Mechanical requirements and tests (5.3);
- Functional requirements and tests for power supplies, I/Os and other components (Clause 6);
- EMC requirements and tests (Clause 7);
- Marking and documentation requirements (Clause 8).

Product safety requirements for PLC and the other types of industrial control equipment now in the scope of this standard are specified in IEC 61010-2-201, which replaces the requirements of Clauses 11 to 14 of IEC 61131-2:2007.

The operating conditions and the temperature derating for altitudes are aligned with IEC 61010-2-201:–¹.

¹ Under preparation. Stage at the time of publication: IEC /CDV 61010-2-201:2016.